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| Notice of References Cited | Application/Control No. 10/034,732 | Applicant(s)/Patent Under Reexamination BOBBA ET AL. | |
| | Examiner Chris C. Chu | Art Unit 2815 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-6566758 - B1 ✓ | 05-2003 | Trivedi et al. | 257/774 |
| | B | US-5248903 - A ✓ | 09-1993 | Heim | 257/748 |
| | C | US-6313537 - B1 ✓ | 11-2001 | Lee et al. | 257/758 |
| | D | US-5404047 - A ✓ | 04-1995 | Rostoker et al. | 257/786 |
| | E | US-5502337 - A ✓ | 03-1996 | Nozaki | 257/773 |
| | F | US-5736791 - A ✓ | 04-1998 | Fujiki et al. | 257/781 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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